Issue	Classification

Application No.	Applicant(s)	_
10/688,437	LIN, HUNG CHANG	
Examiner	Art Unit	

2816

ISSUE CLASSIFICATION													
ORIGIN	***************************************					•••••••	REFEREN	******					
CLASS	SUBCLASS	CLASS			SUBCLA	S PER BLOCK)							
52/	432	33 b	296										
INTERNATIONAL C	ASSIFICATION												
403K	17/60												
	1												
	,												
	7												
	, ,												
	/												
/ ا			\frown										
			TUANT.LAM (2/1/04 PRIMARY EXAMINER (Date)					Total Claims Allowed: と					
74.01. 400	xaminer) (Date)		V			4							
I /iki_OMO	MW 121 nts Examiner) (Da	ار برار کا		TUAI	NT.LAM	12/1	lou.		O.G. Print Claim(s)			G. I t Fig.	
Legal Instrume	nts Examiner) (Da	ate) 9	FA	MARY	·EXAMINE	R(Date)	1			Ì,	1		
L//												<i>'</i>	
Claims renu	mbered in the sa	me orde	r as prese	nted by	applicant	Тос	PA	I			□ R.	1.47	
						·							
Final	Final	Final	Original	Final	Original	Final	Original		Final	Original	Final	Original	
" ŏ	L Q	L	ō	L	ō	<u> </u>	Ö		ш	ö	l ii.	Ori	
1	31		61		91		121	-	1	51	_	181	
2	32		62		92		122			52		182	
3	33		63		93		123			53		183	
5	34		64 65		94 95		124			54		184	
6	36		66		96		125 126	-		55 56		185 186	
7	37		67		97		127			57		187	
8	38		68		98		128		1	58		188	
9	39	-	69		99		129	-		59		189	
10	40		70 71		100	-	130 131	-		60		190	
12	42	1	72		102		132	-		61 62		191 192	
13	43		73		103		133			63	$\vdash \vdash \vdash$	193	
14	44		74		104		134		_ 1	64		194	
15	45		75	\vdash	105		135	<u> </u>	$\overline{}$	65		195	
16	46		76 77		106 107	-	136 137	-		66 67		196	
18	48		78	\vdash	108		138	\vdash		68	-	197 198	
19	49		79		109		139	一		69		199	
20	50		80		110		140		1	70		200	
21	51		81		111	<u></u>	141	_		71		201	
22	52		82		112		142	\vdash		72		202	
24	54		84		114		143	\vdash		73 74		203	
25	55		85		115		145	 		75		205	
26	. 56		86		116		146		1	76		206	
27	57		87		117		147	L		77		207	
28	58 59		88		118	<u></u>	148	<u> </u>		78	\vdash	208	
30	60	1	89 90		119		149 150	\vdash		79 80		209	
U.S. Patent and Trac	·				120	<u> </u>	100			of Donor N	1	210	

Tuan T. Lam